## Application/Control No. Applicant(s)/Patent Under Reexamination 10/702,442 KIN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Kin-Chan Chen 1765 **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY US-5,378,317 01-1995 Kashiwase et al. Α 438/704 US-6,517,998 02-2003 Noda et al. 430/329 В 05-2003 Scovell, Tim US-6,558,477 С 134/30 D US-6,622,738 09-2003 Scovell, Tim 134/61 US-6,696,228 02-2004 Muraoka et al. Ε 430/329 US-2002/0011257 01-2002 DEGENDT et al. F 134/3 US-G US-Н USı US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS**

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